IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of Applicants:

Date: September 27, 2001

Beaman et al.

Group Art Unit: 2858

Serial No.: 09/382,834

Examiner: V. Nguyen

Filed: August 25, 1999

Docket No.: YO993-028BX

For: HIGH DENSITY INTEGRATED CIRCUIT APPARATUS,

TEST PROBE AND METHODS OF USE THEREOF

Assistant Commissioner for Patents Washington, D. C. 20231

CERTIFICATE OF FACSIMILE TRANSMISSION

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Dr. Daniel P. Morris, Est

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AMENDMENT

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In response to Office Action dated July 31, 2001, please consider the following:

REMARKS

REQUEST FOR WITHDRAWAL OF FINAL REJECTION

Claims 30-51 have been rejected under 35 USC 102(b) as being anticipated by Bove et al. In the prior office action claims 33, 34, 36, 37, 42, 47-49 and 52 were not rejected under 35 USC 102(b) as being anticipated by Bove et al. These claims were written in independent form in Applicants' response dated May 7, 2001. The Examiner for the

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